TS1002/TS1004

THE ONLY 0.8V/0.6µA RAIL-TO-RAIL DUAL/QUAD OP AMPS

FEATURES

Single 0.65V to 2.5V Operation
Supply current: 0.6µA per amplifier (typ)
Offset voltage: 0.5mV (typ)
Low TCV_{OS}: 10µV/°C (typ)
A_{VOL} Driving 100kΩ Load: 90dB (min)
Unity Gain Stable
Rail-to-rail Input and Output
No Output Phase Reversal
Packaging: TS1002 – 8-pin MSOP
TS1004 – 14-pin TSSOP

APPLICATIONS

Battery/Solar-Powered Instrumentation
Portable Gas Monitors
Low-voltage Signal Processing
Nanopower Active Filters
Wireless Remote Sensors
Battery-powered Industrial Sensors
Active RFID Readers
Powerline or Battery Current Sensing
Handheld/Portable POS Terminals

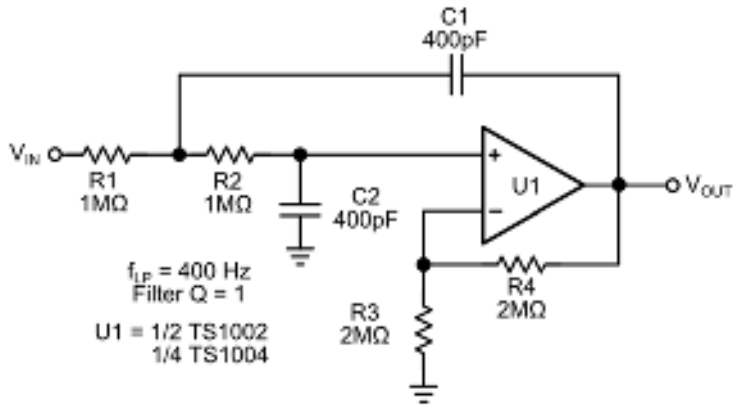
DESCRIPTION

The TS1002 and the TS1004 are the industry's first and only dual and quad single-supply, precision CMOS operational amplifiers fully specified to operate at 0.8V while consuming less than 0.6µA supply current per amplifier. Optimized for ultra-long-life battery-powered applications, the TS1002 and the TS1004 join the TS1001 operational amplifier in the "NanoWatt Analog™" high-performance analog integrated circuits portfolio. Both op amps exhibit a typical offset voltage of 0.5mV, a typical input bias current of 25pA, and rail-to-rail input and output stages. The TS1002 and the TS1004 can operate from single-supply voltages from 0.65V to 2.5V.

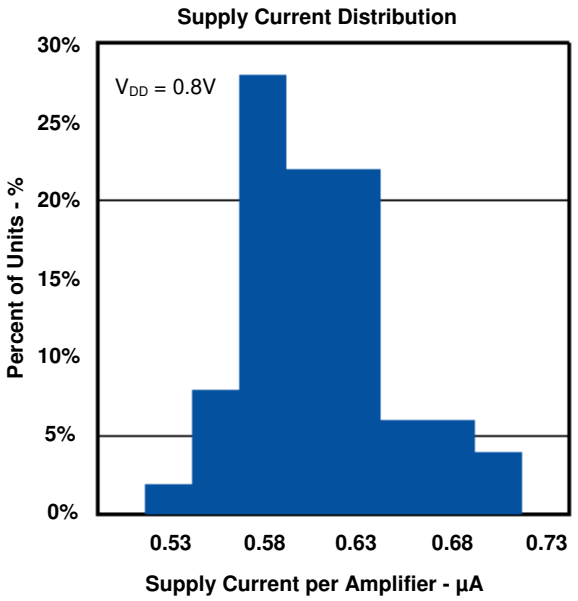
The TS1002/TS1004's combined features make either an excellent choice in applications where very low supply current and low operating supply voltage translate into very long equipment operating time. Applications include: nanopower active filters, wireless remote sensors, battery and powerline current sensors, portable gas monitors, and handheld/portable POS terminals.

The TS1002 and the TS1004 are fully specified at VDD = 0.8V and over the industrial temperature range (−40°C to +85°C). The TS1002 is available in PCB-space saving 8-lead MSOP surface-mount packages. The TS1004 is available in a 14-pin TSSOP package.

TYPICAL APPLICATION CIRCUIT



A NanoWatt 2-Pole Sallen-Key Low-Pass Filter



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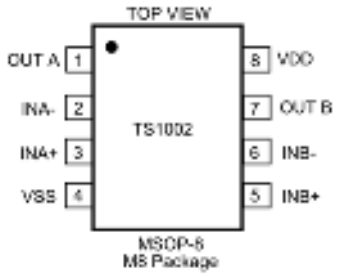
ABSOLUTE MAXIMUM RATINGS

Total Supply Voltage (V_{DD} to V_{SS}) ..... +2.75 V
Voltage Inputs (IN+, IN-) ..... (V_{SS} - 0.3V) to (V_{DD} + 0.3V)
Differential Input Voltage ..... ±2.75 V
Input Current (IN+, IN-) ..... 20 mA
Output Short-Circuit Duration to GND ..... Indefinite
Continuous Power Dissipation (T_A = +70°C)
8-Pin MSOP (Derate 7mW/°C above +70°C) ..... 450 mW
14-pin TSSOP (Derate 8.3mW/°C above +70°C)
..... 500 mW

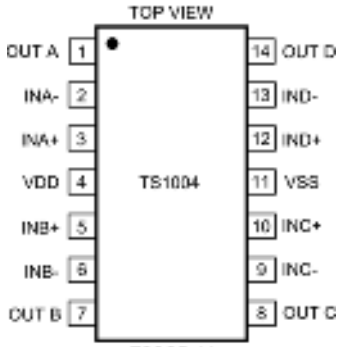
Operating Temperature Range ..... -40°C to +85°C
Junction Temperature ..... +150°C
Storage Temperature Range ..... -65°C to +150°C
Lead Temperature (soldering, 10s) ..... +300°

Electrical and thermal stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to any absolute maximum rating conditions for extended periods may affect device reliability and lifetime.

PACKAGE/ORDERING INFORMATION



MSOP-8
M8 Package



TSSOP-14
T14 Package

TAPE & REEL ORDER NUMBER	PART MARKING	PACKAGE QUANTITY	TAPE & REEL ORDER NUMBER	PART MARKING	PACKAGE QUANTITY
TS1002IM8	TADJ	-----	TS1004IT14	T1004I	-----
TS1002IM8T		2500	TS1004IT14T		2500

Lead-free Program: Silicon Labs supplies only lead-free packaging.

Consult Silicon Labs for products specified with wider operating temperature ranges.

ELECTRICAL CHARACTERISTICS

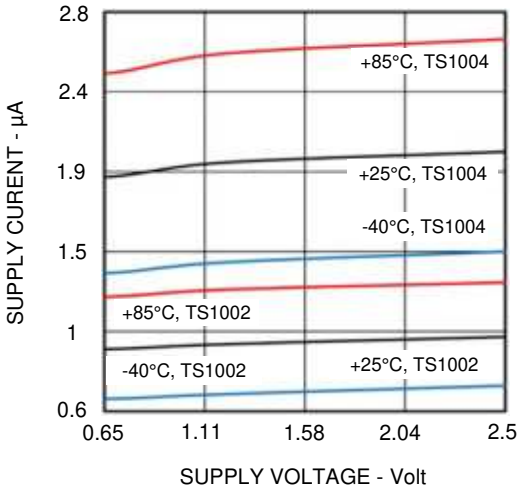
V_{DD} = +0.8V, V_{SS} = 0V, V_{INCM} = V_{SS}; R_L = 100kΩ to (V_{DD}-V_{SS})/2; T_A = -40°C to +85°C, unless otherwise noted. Typical values are at T_A = +25°C. See Note 1

Parameters	Symbol	Conditions		Min	Typ	Max	Units
Supply Voltage Range	V_{DD}-V_{SS}			0.65	0.8	2.5	V
Supply Current	I_{SY}	TS1002; R_L = Open circuit	T_A = 25°C		1.2	1.6	µA
			-40°C ≤ T_A ≤ 85°C			2	
		TS1004; R_L = Open circuit	T_A = 25°C		2.4	3.2	µA
			-40°C ≤ T_A ≤ 85°C			4	
Input Offset Voltage	V_{OS}	V_{IN} = V_{SS} or V_{DD}	T_A = 25°C		0.5	3	mV
			-40°C ≤ T_A ≤ 85°C			5	
Input Offset Voltage Drift	TCV_{OS}				10		µV/°C
Input Bias Current	I_{IN+}, I_{IN-}	V_{IN+}, V_{IN-} = (V_{DD} - V_{SS})/2	T_A = 25°C		0.025		nA
			-40°C ≤ T_A ≤ 85°C			20	
Input Offset Current	I_{OS}	Specified as I_{IN+} - I_{IN-} V_{IN+}, V_{IN-} = (V_{DD} - V_{SS})/2	T_A = 25°C		0.01		nA
			-40°C ≤ T_A ≤ 85°C			2	
Input Voltage Range	IVR	Guaranteed by Input Offset Voltage Test		V_{SS}		V_{DD}	V
Common-Mode Rejection Ratio	CMRR	0V ≤ $V_{IN(CM)}$ ≤ 0.4V		50	74		dB
Power Supply Rejection Ratio	PSRR	0.65V ≤ (V_{DD} - V_{SS}) ≤ 2.5V		50	74		dB
Output Voltage High	V_{OH}	Specified as V_{DD} - V_{OUT}, R_L = 100kΩ to V_{SS}	T_A = 25°C		1.2	2	mV
			-40°C ≤ T_A ≤ 85°C			2.5	
		Specified as V_{DD} - V_{OUT}, R_L = 10kΩ to V_{SS}	T_A = 25°C		10	16	
			-40°C ≤ T_A ≤ 85°C			20	
Output Voltage Low	V_{OL}	Specified as V_{OUT} - V_{SS}, R_L = 100kΩ to V_{DD}	T_A = 25°C		0.4	0.6	mV
			-40°C ≤ T_A ≤ 85°C			1	
		Specified as V_{OUT} - V_{SS}, R_L = 10kΩ to V_{DD}	T_A = 25°C		5	7	
			-40°C ≤ T_A ≤ 85°C			10	
Short-circuit Current	I_{SC+}	V_{OUT} = V_{SS}	T_A = 25°C	0.5	1.5		mA
			-40°C ≤ T_A ≤ 85°C	0.3			
	I_{SC-}	V_{OUT} = V_{DD}	T_A = 25°C	4.5	11		
			-40°C ≤ T_A ≤ 85°C	3			
Open-loop Voltage Gain	A_{VOL}	V_{SS}+50mV ≤ V_{OUT} ≤ V_{DD}-50mV	T_A = 25°C	90	104		dB
			-40°C ≤ T_A ≤ 85°C	85			
Gain-Bandwidth Product	GBWP	R_L = 100kΩ to V_{SS}, C_L = 20pF			4		kHz
Phase Margin	φ_M	Unity-gain Crossover, R_L = 100kΩ to V_{SS}, C_L = 20pF			70		degrees
Slew Rate	SR	R_L = 100kΩ to V_{SS}, A_{VCL} = +1V/V			1.5		V/ms
Full-power Bandwidth	FPBW	FPBW = SR/(π • $V_{OUT,PP}$); $V_{OUT,PP}$ = 0.7V_{PP}			680		Hz
Input Voltage Noise Density	e_n	f = 1kHz			0.6		µV/√Hz
Input Current Noise Density	i_n	f = 1kHz			10		pA/√Hz

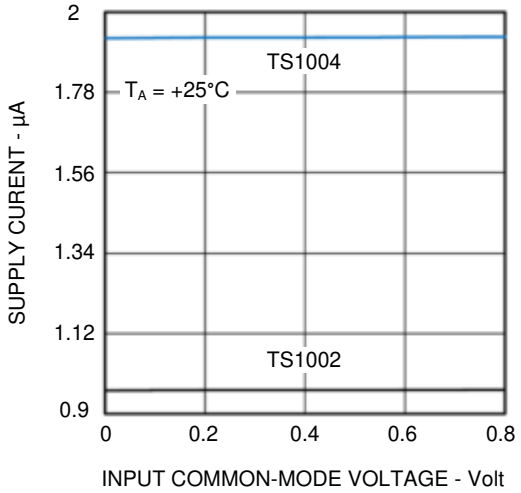
Note 1: All specifications are 100% tested at T_A = +25°C. Specification limits over temperature (T_A = T_{MIN} to T_{MAX}) are guaranteed by device characterization, not production tested.

TYPICAL PERFORMANCE CHARACTERISTICS

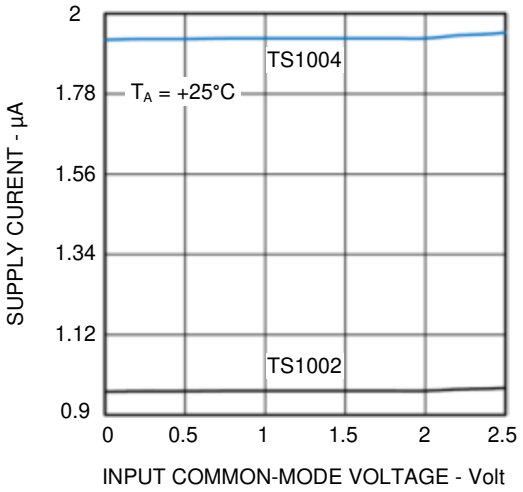
Total Supply Current vs Supply Voltage



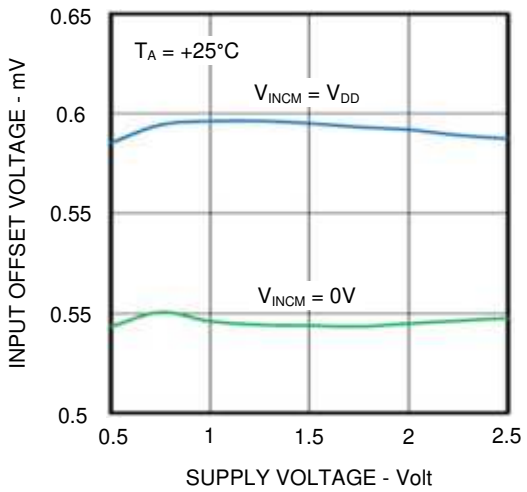
Total Supply Current vs Input Common-Mode Voltage



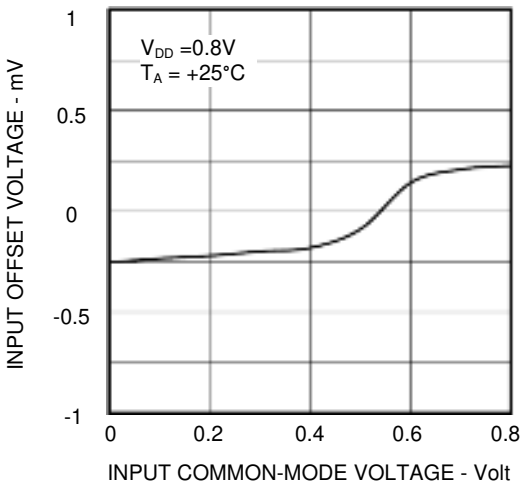
Total Supply Current vs Input Common-Mode Voltage



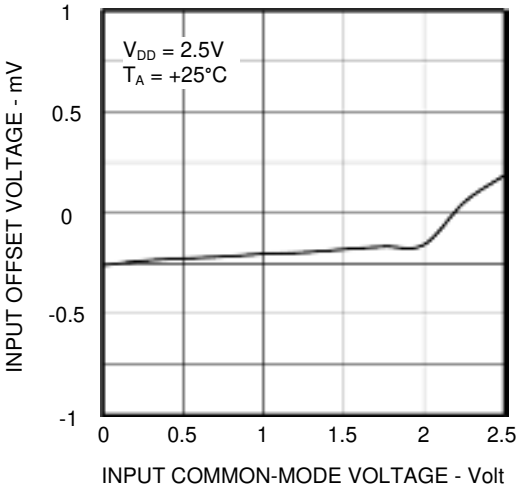
Input Offset Voltage vs Supply Voltage



Input Offset Voltage vs Input Common-Mode Voltage

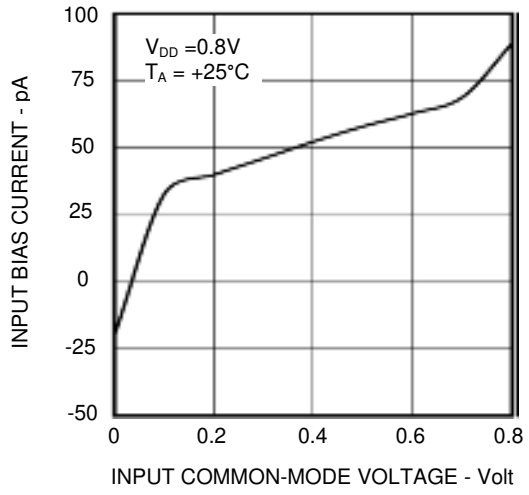


Input Offset Voltage vs Input Common-Mode Voltage

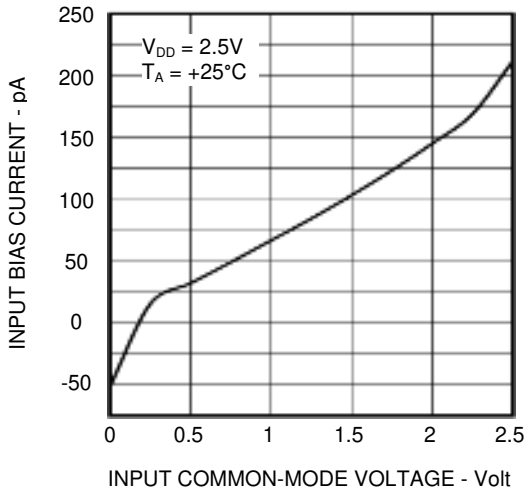


TYPICAL PERFORMANCE CHARACTERISTICS

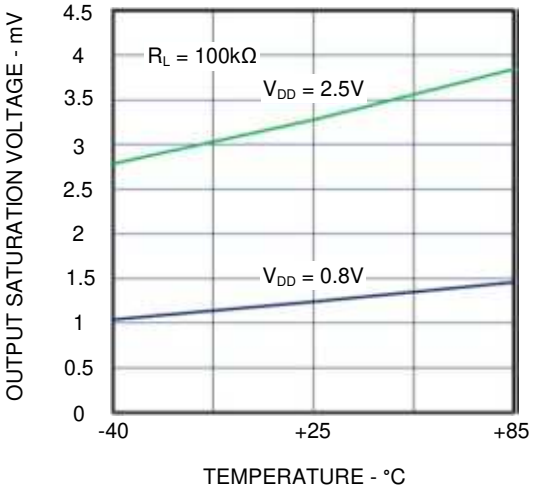
Input Bias Current (I_{IN+}, I_{IN-}) vs Input Common-Mode Voltage



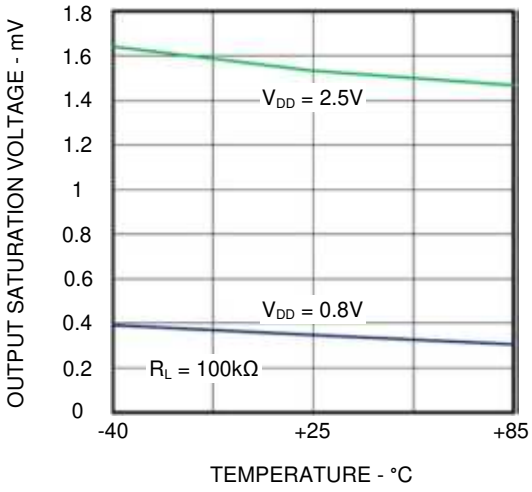
Input Bias Current (I_{IN+}, I_{IN-}) vs Input Common-Mode Voltage



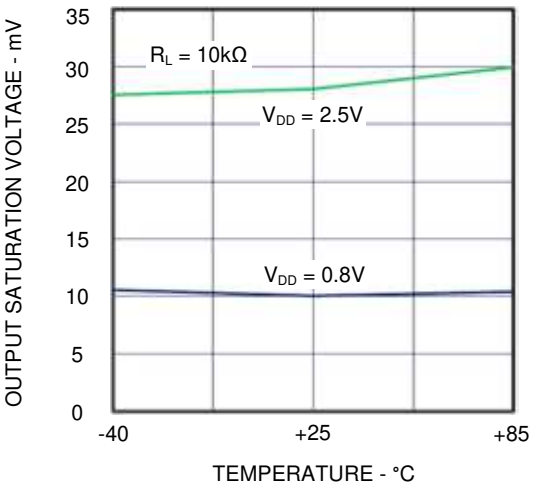
Output Voltage High (V_{OH}) vs Temperature, R_{LOAD} =100kΩ



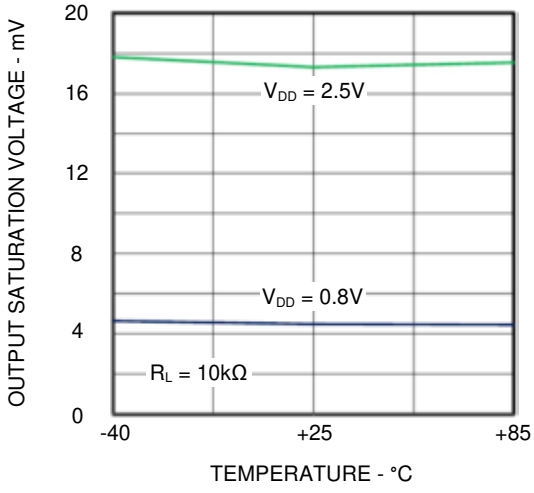
Output Voltage Low (V_{OL}) vs Temperature, R_{LOAD} =100kΩ



Output Voltage High (V_{OH}) vs Temperature, R_{LOAD} =10kΩ

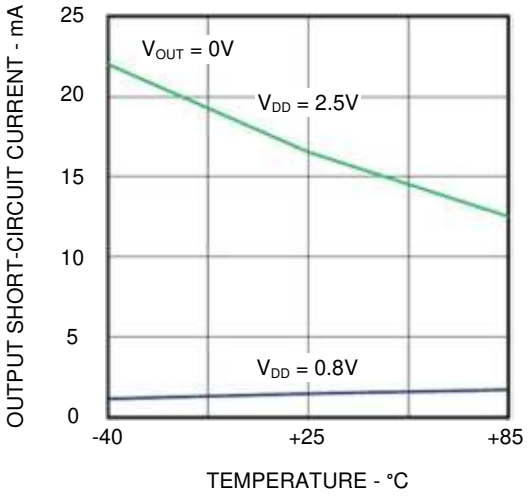


Output Voltage Low (V_{OL}) vs Temperature, R_{LOAD} =10kΩ

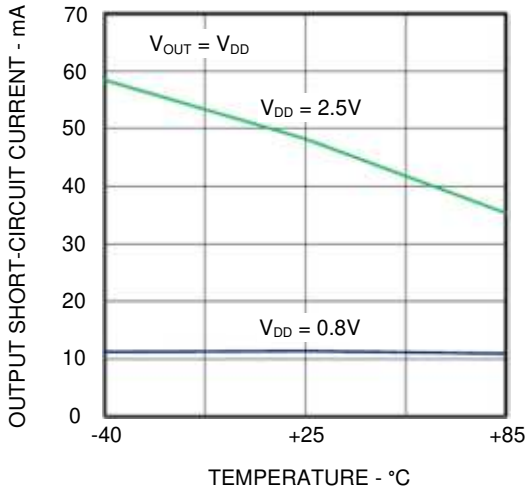


TYPICAL PERFORMANCE CHARACTERISTICS

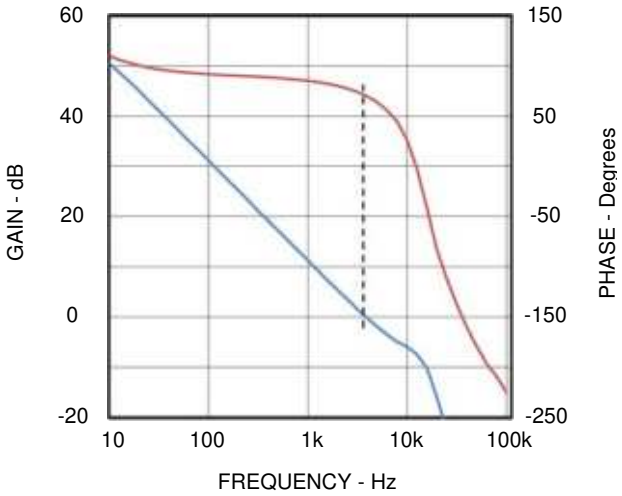
Output Short Circuit Current, I_{SC+} vs Temperature



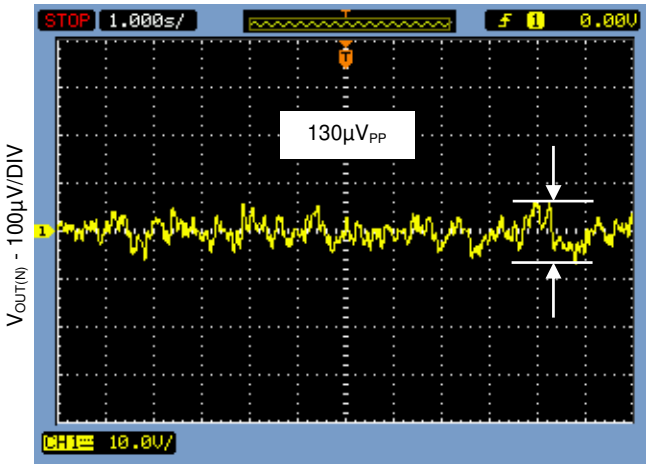
Output Short Circuit Current, I_{SC-} vs Temperature



Gain and Phase vs. Frequency

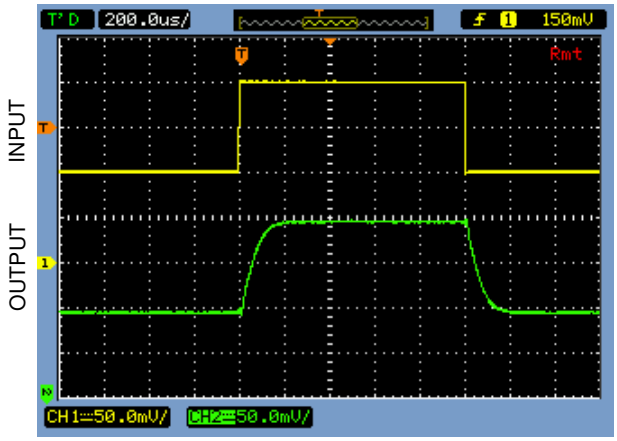


0.1Hz to 10Hz Output Voltage Noise



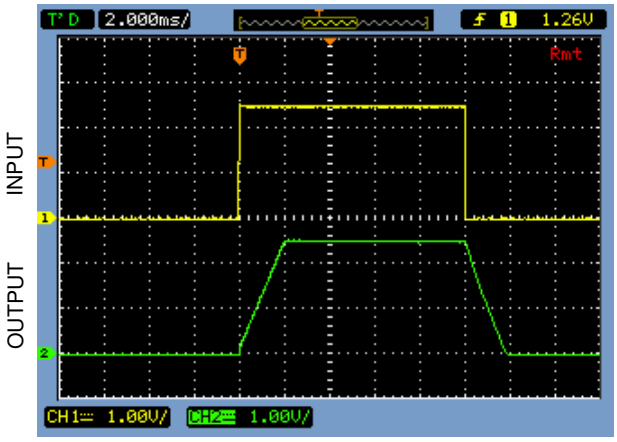
1 Second/DIV

Small-Signal Transient Response
V_{DD} = 2.5V, V_{SS} = GND, R_{LOAD} = 100kΩ, C_{LOAD} = 15pF



200µs/DIV

Large-Signal Transient Response
V_{DD} = 2.5V, V_{SS} = GND, R_{LOAD} = 100kΩ, C_{LOAD} = 15pF



2ms/DIV

PIN FUNCTIONS

Pin		Label	Function
TS1002 MSOP	TS1004 TSSOP		
1, 7	1, 7, 8, 14	OUT	Amplifier Outputs: A, B – TS1002; A, B, C, D – TS1004
4	7	V_{SS}	Negative Supply or Analog GND. If applying a negative voltage to this pin, connect a 0.1µF capacitor from this pin to analog GND.
3, 5	3, 5, 10, 12	+IN	Amplifier Non-inverting Inputs: A, B – TS1002; A, B, C, D – TS1004
2, 6	2, 6, 9, 13	-IN	Amplifier Inverting Inputs: A, B – TS1002; A, B, C, D – TS1004
8	14	V_{DD}	Positive Supply Connection. Connect a 0.1µF bypass capacitor from this pin to analog GND.

THEORY OF OPERATION

The TS1002 and the TS1004 are fully functional for input signals from the negative supply (V_{SS} or GND) to the positive supply (V_{DD}). Their input stages consist of two differential amplifiers, a p-channel CMOS stage and an n-channel CMOS stage that are active over different ranges of the input common mode voltage. The p-channel input pair is active for input common mode voltages, V_{INCM}, between the negative supply to approximately 0.4V below the positive supply. As the common-mode input voltage moves closer towards V_{DD}, an internal current mirror activates the n-channel input pair differential pair. The p-channel input pair becomes inactive for the balance of the input common mode voltage range up to the positive supply. Because both input stages have their own offset voltage (V_{OS}) characteristic, the offset voltage of these amplifiers is a function of the applied input common-mode voltage, V_{INCM}. The V_{OS} has a crossover point at ~0.4V from V_{DD} (Refer to the V_{OS} vs. V_{CM} curve in the Typical Operating Characteristics section). Caution should be taken in applications where the input signal amplitude is comparable to the amplifiers' V_{OS} value and/or the design requires high accuracy. In these situations, it is necessary for the input signal to avoid the crossover point. In addition, amplifier parameters such as PSRR and CMRR which involve the input offset voltage will also be affected by changes in the input common-mode voltage across the differential pair transition region.

The amplifiers' second stage is a folded-cascode transistor arrangement that converts the input stage differential signals into a single-ended output. A complementary drive generator supplies current to the output transistors that swing rail to rail.

The amplifiers' output stage voltage swings within 1.2mV from the rails at 0.8V supply when driving an output load of 100kΩ - which provides the maximum possible dynamic range at the output. This is particularly important when operating on low supply voltages. When driving a stiffer 10kΩ load, the amplifiers' output swings within 10mV of V_{DD} and within 5mV of V_{SS} (or GND).

APPLICATIONS INFORMATION

Portable Gas Detection Sensor Amplifier

Gas sensors are used in many different industrial and medical applications. Gas sensors generate a current that is proportional to the percentage of a particular gas concentration sensed in an air sample. This output current flows through a load resistor and the resultant voltage drop is amplified. Depending on the sensed gas and sensitivity of the sensor, the output current can be in the range of tens of microamperes to a few milliamperes. Gas sensor datasheets often specify a recommended load resistor value or a range of load resistors from which to choose.

There are two main applications for oxygen sensors – applications which sense oxygen when it is abundantly present (that is, in air or near an oxygen tank) and those which detect traces of oxygen in parts-per-million concentration. In medical applications, oxygen sensors are used when air quality or oxygen delivered to a patient needs to be monitored. In fresh air, the concentration of oxygen

is 20.9% and air samples containing less than 18% oxygen are considered dangerous. In industrial applications, oxygen sensors are used to detect the absence of oxygen; for example, vacuum-packaging of food products is one example.

The circuit in Figure 1 illustrates a typical implementation used to amplify the output of an oxygen detector. Either amplifier makes an

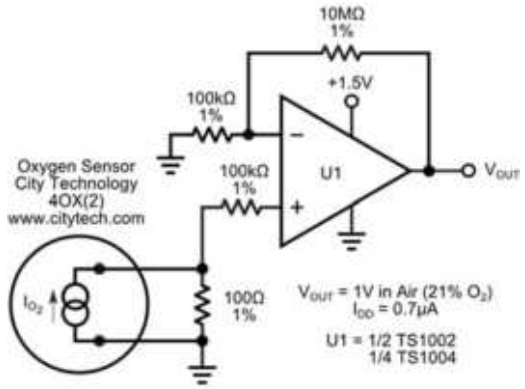


Figure 1: A Nanopower, Precision Oxygen Gas Sensor Amplifier.

excellent choice for this application as it only draws 0.6µA of supply current per amplifier and operates on supply voltages down to 0.65V. With the components shown in the figure, the circuit consumes less than 0.7 µA of supply current ensuring that small form-factor single- or button-cell batteries (exhibiting low mAh charge ratings) could last beyond the operating life of the oxygen sensor. The precision specifications of these amplifiers, such as their low offset voltage, low TCV_{OS}, low input bias current, high CMRR, and high PSRR are other factors which make these amplifiers excellent choices for this application. Since oxygen sensors typically exhibit an operating life of one to two years, an oxygen sensor amplifier built around one of these amplifiers can operate from a conventionally-available single 1.5-V alkaline AA battery for over 290 years! At such low power consumption from a single cell, the oxygen sensor could be replaced over 150 times before the battery requires replacing!

NanoWatt, Buffered Single-pole Low-Pass Filters

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. As shown in Figure 2, the simplest way to achieve this objective is to use an RC filter at the noninverting terminal of the amplifier.

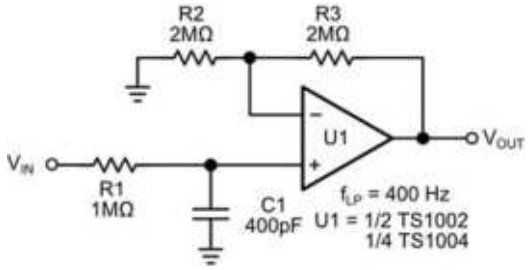


Figure 2: A Simple, Single-pole Active Low-Pass Filter.

If additional attenuation is needed, a two-pole Sallen-Key filter can be used to provide the additional attenuation as shown in Figure 3.

For best results, the filter's cutoff frequency should be 8 to 10 times lower than the amplfier's crossover

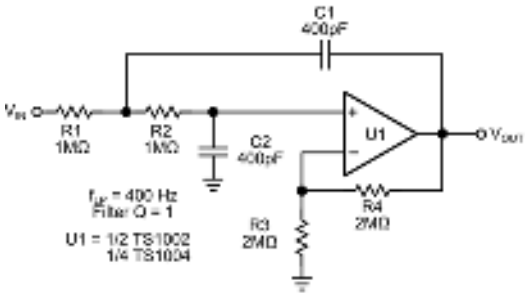


Figure 3: A Nanopower 2-Pole Sallen-Key Low-Pass Filter.

frequency. Additional operational amplifier phase margin shift can be avoided if the amplifier bandwidth-to-signal bandwidth ratio is greater than 8.

The design equations for the 2-pole Sallen-Key low-pass filter are given below with component values selected to set a 400Hz low-pass filter cutoff frequency:

R1 = R2 = R = 1MΩ
C1 = C2 = C = 400pF
Q = Filter Peaking Factor = 1
f–3dB = 1/(2 x π x RC) = 400 Hz
R3 = R4/(2-1/Q); with Q = 1, R3 = R4.

A Single +1.5 V Supply, Two Op Amp Instrumentation Amplifier

The amplifiers' ultra-low supply current and ultra-low voltage operation make them ideal for battery-powered applications such as the instrumentation amplifier shown in Figure 4 using a TS1002.

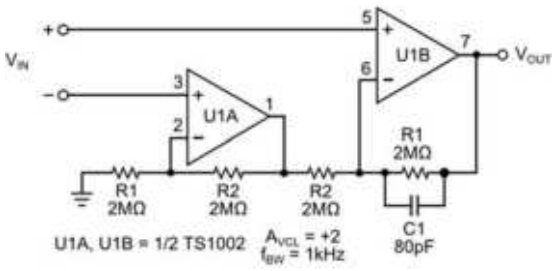


Figure 4: A Two Op Amp Instrumentation Amplifier.

The circuit utilizes the classic two op amp instrumentation amplifier topology with four resistors to set the gain. The equation is simply that of a noninverting amplifier as shown in the figure. The two resistors labeled R1 should be closely matched to each other as well as both resistors labeled R2 to ensure acceptable common-mode rejection performance.

Resistor networks ensure the closest matching as well as matched drifts for good temperature stability. Capacitor C1 is included to limit the bandwidth and, therefore, the noise in sensitive applications. The value of this capacitor should be adjusted depending on the desired closed-loop bandwidth of the instrumentation amplifier. The RC combination creates a pole at a frequency equal to $1/(2 \pi \times R1C1)$. If the AC-CMRR is critical, then a matched capacitor to C1 should be included across the second resistor labeled R1.

Because these amplifiers accept rail-to-rail inputs, their input common mode range includes both ground and the positive supply of 1.5V. Furthermore, their rail-to-rail output range ensures the widest signal range possible and maximizes the dynamic range of the system. Also, with their low supply current of 0.6µA per amplifier, this circuit consumes a quiescent current of only ~1.3µA, yet it still exhibits a 1-kHz bandwidth at a circuit gain of 2.

Driving Capacitive Loads

While the amplifiers' internal gain-bandwidth product is 4kHz, both are capable of driving capacitive loads up to 50pF in voltage follower configurations without any additional components. In many applications, however, an operational amplifier is required to drive much larger capacitive loads. The amplifier's output impedance and a large capacitive load create additional phase lag that further reduces the amplifier's phase margin. If enough phase delay is introduced, the amplifier's phase margin is reduced. The effect is quite evident when the transient response is observed as there will appear noticeable peaking/ringing in the output transient response.

If any amplifier is used in an application that requires driving larger capacitive loads, an isolation resistor between the output and the capacitive load should be used as illustrated in Figure 5.

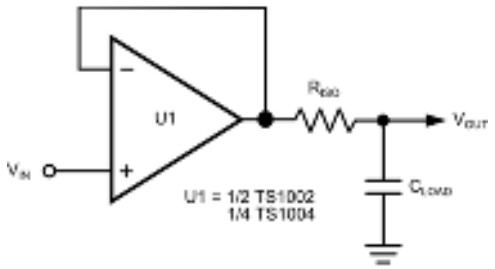


Figure 5: Using an External Resistor to Isolate a C_{LOAD} from the Amplifer's Output.

Table 1 illustrates a range of R_{ISO} values as a function of the external C_{LOAD} on the output of these amplifiers. The power supply voltage applied on the these amplifiers at which these resistor values were determined empirically was 1.8V. The oscilloscope capture shown in Figure 6 illustrates a typical transient response obtained with a C_{LOAD} = 500pF and an R_{ISO} = 50kΩ. Note that as C_{LOAD} is increased a smaller R_{ISO} is needed for optimal transient response.

External Capacitive Load, C_{LOAD}	External Output Isolation Resistor, R_{ISO}
0-50pF	Not Required
100pF	120kΩ
500pF	50kΩ
1nF	33kΩ
5nF	18kΩ
10nF	13kΩ

In the event that an external R_{LOAD} in parallel with C_{LOAD} appears in the application, the use of an R_{ISO} results in gain accuracy loss because the external series R_{ISO} forms a voltage-divider with the external load resistor R_{LOAD}.

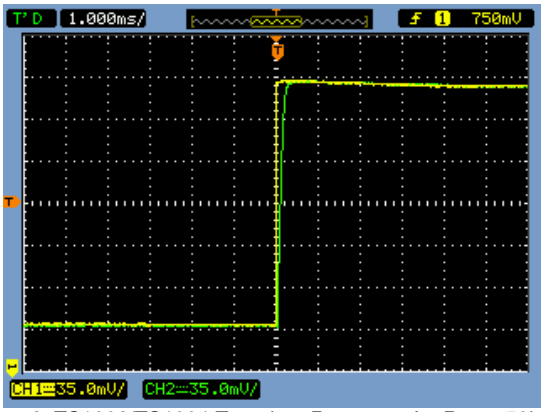


Figure 6: TS1002/TS1004 Transient Response for R_{ISO} = 50kΩ and C_{LOAD} = 500pF.

Configuring the TS1002 or the TS1004 into a Nanowatt Analog Comparator

Although optimized for use as an operational amplifier, these amplifiers can also be used as a rail-to-rail I/O comparator as illustrated in Figure 7.

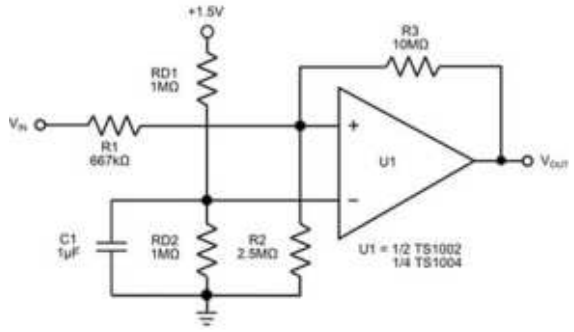


Figure 7: A NanoWatt Analog Comparator with User-Programmable Hysteresis.

External hysteresis can be employed to minimize the risk of output oscillation. The positive feedback circuit causes the input threshold to change when the output voltage changes state. The diagram in Figure 8 illustrates the amplifiers' analog comparator hysteresis band and output transfer characteristic.

The design of an analog comparator using the TS1002 or the TS1004 is straightforward. In this application, a 1.5-V power supply (V_{DD}) was used and the resistor divider network formed by RD1 and RD2 generated a convenient reference voltage

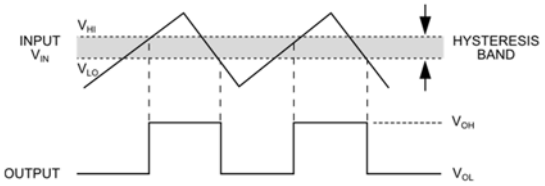


Figure 8: Analog Comparator Hysteresis Band and Output Switching Points.

(V_{REF}) for the circuit at ½ the supply voltage, or 0.75V, while keeping the current drawn by this resistor divider low. Capacitor C1 is used to filter any extraneous noise that could couple into the amplifer's inverting input.

In this application, the desired hysteresis band was set to 100mV (V_{HYB}) with a desired high trip-point (V_{HI}) set at 1V and a desired low trip-point (V_{LO}) set at 0.9V.

Since these amplifers draw very little supply current (0.6µA per amplifier, typical), it is desired that the design of an analog comparator using these amplfiers should also use as little current as practical. The first step in the design, therefore, was to set the feedback resistor R3:

$$R3 = 10M\Omega$$

Calculating a value for R1 is given by the following expression:

$$R1 = R3 \times (V_{HYB}/V_{DD})$$

Substituting V_{HYB} = 100mV, V_{DD} = 1.5V, and R3 = 10MΩ into the equation above yields:

$$R1 = 667k\Omega$$

The following expression was then used to calculate a value for R2:

$$R2 = 1/[V_{HI}/(V_{REF} \times R1) - (1/R1) - (1/R3)]$$

Substituting V_{HI} = 1V, V_{REF} = 0.75V, R1 = 667kΩ, and R3 = 10MΩ into the above expression yields:

$$R2 = 2.5M\Omega$$

Printed Circuit Board Layout Considerations

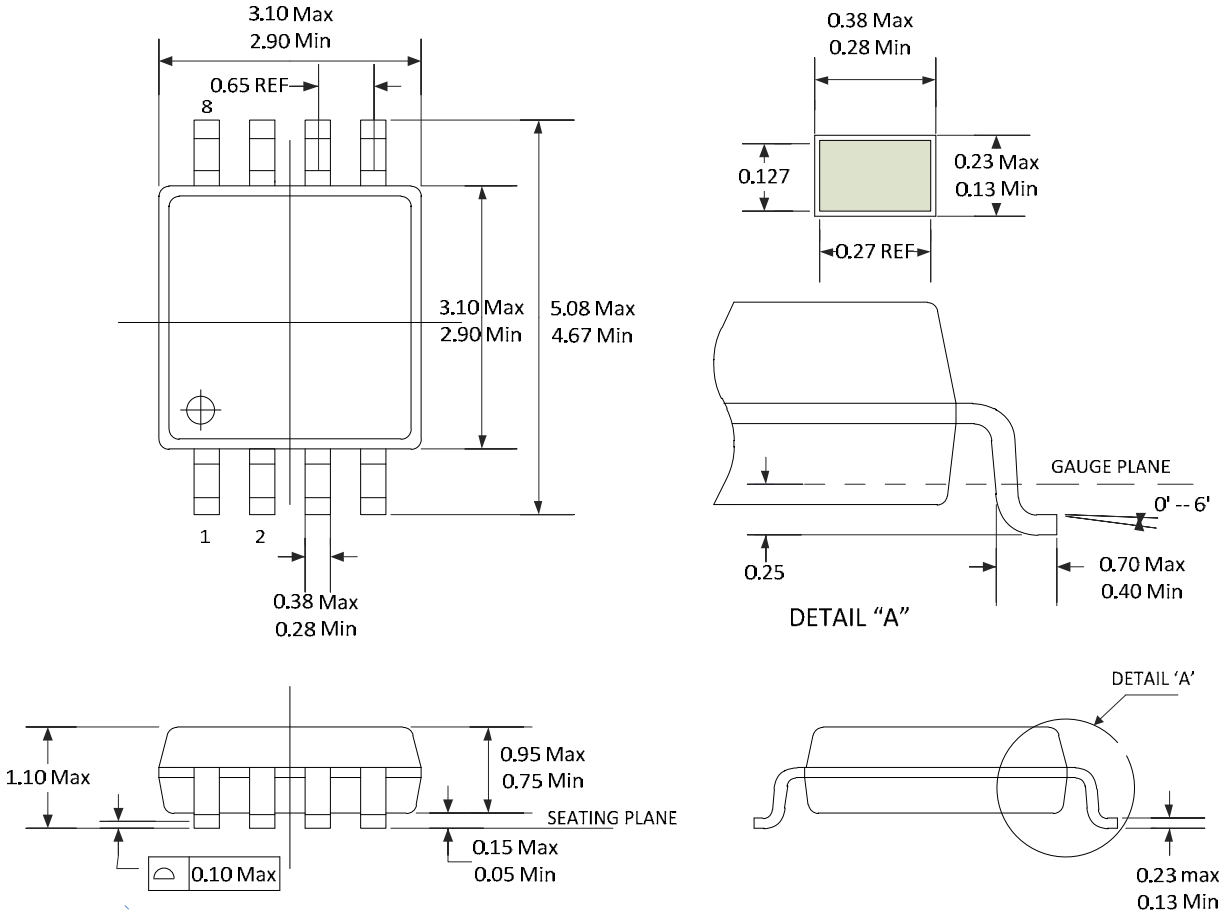
Even though these amplifiers operate from a single 0.65V to 2.5V power supply and consume very little supply current, it is always good engineering practice to bypass the power supplies pins with a 0.1µF ceramic capacitor placed in close proximity to the V_{DD} and V_{SS} (or GND) pins.

Good pcb layout techniques and analog ground plane management improve the performance of any analog circuit by decreasing the amount of stray capacitance that could be introduced at the op amp's inputs and outputs. Excess stray capacitance can easily couple noise into the input leads of the op amp and excess stray capacitance at the output will add to any external capacitive load. Therefore, PC board trace lengths and external component leads should be kept a short as practical to any of the amplifiers' package pins. Second, it is also good engineering practice to route/remove any analog ground plane from the inputs and the output pins of these amplifiers.

PACKAGE OUTLINE DRAWING

8-Pin MSOP Package Outline Drawing

(N.B., Drawings are not to scale)



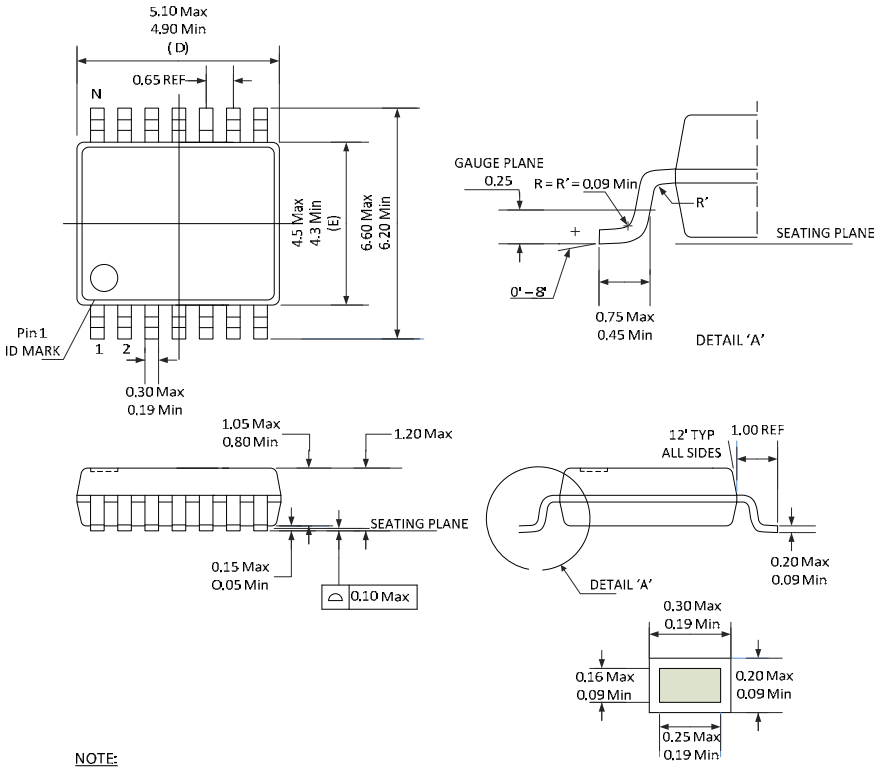
NOTE:

1. PACKAGE LENGTH DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
2. PACKAGE WIDTH DOES NOT INCLUDE INTERLEAD FLASH OR PROTUSIONS.
3. CONTROLLING DIMENSION IN MILIMETERS.
4. THIS PART IS COMPLIANT WITH JEDEC MO-187 VARIATIONS AA
5. LEAD SPAN/STAND OFF HEIGHT/COPLANARITY ARE CONSIDERED AS SPECIAL CHARACTERISTIC.

PACKAGE OUTLINE DRAWING

14-Pin TSSOP Package Outline Drawing

(N.B., Drawings are not to scale)



NOTE:

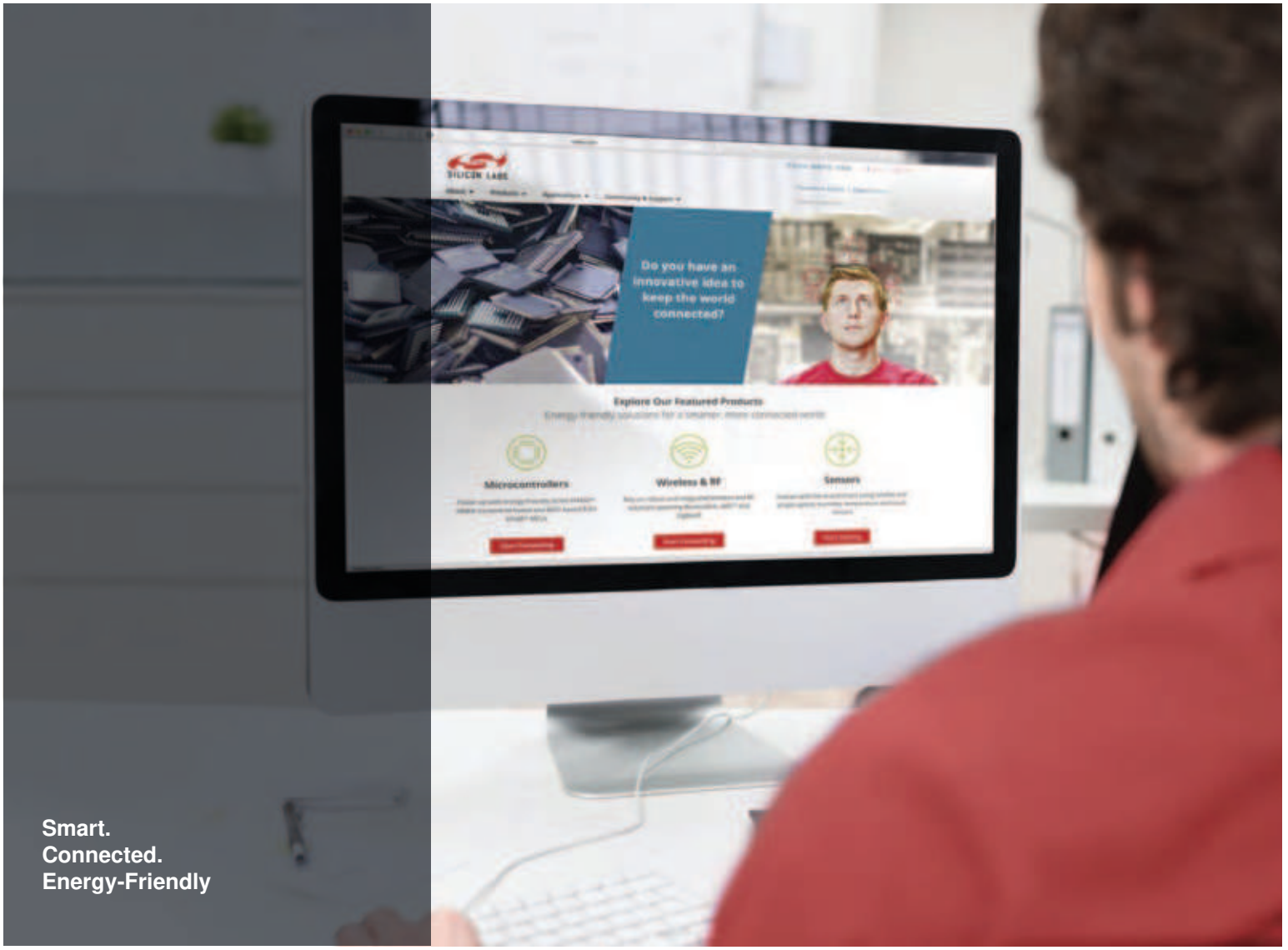
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2. "N" IS THE NUMBER OF TERMINAL POSITIONS.
3. CONTROLLING DIMENSION IN MILIMETERS AND ANGLES IN DEGREES.
4. THIS PART IS COMPLIANT WITH JEDEC SPECIFICATION MO-153 AB-1
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